

Notice of References Cited	Application/Control No. 10/566,156		Applicant(s)/Patent Under Reexamination AKIYAMA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 2004273441 A	09-2004	Japan	YAMAUCHI et al.	
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